

<b>Notice of References Cited</b>	Application/Control No. 09/894,874	Applicant(s)/Patent Under Reexamination YOO ET AL.	
	Examiner Erik Kielin	Art Unit 2813	Page 1 of 1

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	U	Internet article at <a href="http://english.chosun.com/w21data/html/news/200405/200405120051.html">http://english.chosun.com/w21data/html/news/200405/200405120051.html</a> .
	V	Internet article at <a href="http://english.chosun.com/w21data/html/news/200408/200408260053.html">http://english.chosun.com/w21data/html/news/200408/200408260053.html</a> .
	W	
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